FAIRCHILD SEMICONDUCTOR®

May 2009

# FDMS8692

## N-Channel PowerTrench® MOSFET

### 30V, 28A, 9.0mΩ

### Features

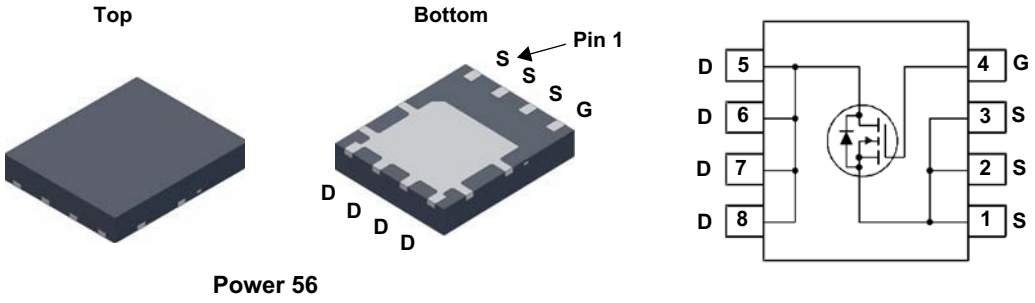
- Max $r_{DS(on)}$ = 9.0mΩ at $V_{GS}$ = 10V, $I_D$ = 12A
- Max $r_{DS(on)}$ = 14.0mΩ at $V_{GS}$ = 4.5V, $I_D$ = 10.5A
- Advanced Package and Silicon combination for low $r_{DS(on)}$ and high efficiency
- MSL1 robust package design
- RoHS Compliant

### General Description

The FDMS8692 has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance.

### Applications

- Low Side for Synchronous Buck to Power Core Processor
- Secondary Side Synchronous Rectifier
- Low Side Switch in POL DC/DC Converter
- Oring FET/ Load Switch




Power 56

## MOSFET Maximum Ratings $T_A$ = 25°C unless otherwise noted

| Symbol | Parameter | | | Ratings | Units |
|---|---|---|---|---|---|
| $V_{DS}$ | Drain to Source Voltage | | | 30 | V |
| $V_{GS}$ | Gate to Source Voltage | | | ±20 | V |
| $I_D$ | Drain Current -Continuous (Package limited) | $T_C$ = 25°C | | 28 | A |
| | -Continuous (Silicon limited) | $T_C$ = 25°C | | 48 | |
| | -Continuous | $T_A$ = 25°C | (Note 1a) | 12 | |
| | -Pulsed | | | 120 | |
| $E_{AS}$ | Single Pulse Avalanche Energy | | (Note 3) | 72 | mJ |
| $P_D$ | Power Dissipation | $T_C$ = 25°C | | 41 | W |
| | Power Dissipation | $T_A$ = 25°C | (Note 1a) | 2.5 | |
| $T_J$, $T_{STG}$ | Operating and Storage Junction Temperature Range | | | -55 to +150 | °C |

### Thermal Characteristics

| | | | |
|---|---|---|---|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 3.0 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 50 | |

### Package Marking and Ordering Information

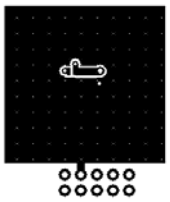
| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|---|---|---|---|---|---|
| FDMS8692 | FDMS8692 | Power 56 | 13'' | 12mm | 3000units |

## Electrical Characteristics $T_J$ = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---|---|---|---|---|---|---|
| **Off Characteristics** | | | | | | |
| $BV_{DSS}$ | Drain to Source Breakdown Voltage | $I_D$ = 250μA, $V_{GS}$ = 0V | 30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D$ = 250μA, referenced to 25°C | | 20 | | mV/°C |
| $I_{DSS}$ | Zero Gate Voltage Drain Current | $V_{DS}$ = 24V, $V_{GS}$ = 0V | | | 1 | μA |
| $I_{GSS}$ | Gate to Source Leakage Current | $V_{GS}$ = ±20V, $V_{DS}$ = 0V | | | ±100 | nA |
| **On Characteristics** | | | | | | |
| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS}$ = $V_{DS}$, $I_D$ = 250μA | 1 | 1.8 | 3 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D$ = 250μA, referenced to 25°C | | -5.4 | | mV/°C |
| $r_{DS(on)}$ | Static Drain to Source On Resistance | $V_{GS}$ = 10V, $I_D$ = 12A | | 7.0 | 9.0 | mΩ |
| | | $V_{GS}$ = 4.5, $I_D$ = 10.5A | | 10.5 | 14.0 | |
| | | $V_{GS}$ = 10V, $I_D$ = 12A, $T_J$ = 125°C | | 10.0 | 13.0 | |
| $g_{FS}$ | Forward Transconductance | $V_{DD}$ = 10V, $I_D$ = 12A | | 58 | | S |
| **Dynamic Characteristics** | | | | | | |
| $C_{iss}$ | Input Capacitance | $V_{DS}$ = 15V, $V_{GS}$ = 0V, f = 1MHz | | 950 | 1265 | pF |
| $C_{oss}$ | Output Capacitance | | | 515 | 685 | pF |
| $C_{rss}$ | Reverse Transfer Capacitance | | | 85 | 130 | pF |
| $R_g$ | Gate Resistance | f = 1MHz | | 1.0 | 2.8 | Ω |
| **Switching Characteristics** | | | | | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD}$ = 15V, $I_D$ = 12A, $V_{GS}$ = 10V, $R_{GEN}$ = 6Ω | | 9 | 18 | ns |
| $t_r$ | Rise Time | | | 3 | 10 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 19 | 34 | ns |
| $t_f$ | Fall Time | | | 2 | 10 | ns |
| $Q_g$ | Total Gate Charge | $V_{GS}$ = 0V to 10V; $V_{DD}$ = 15V, $I_D$ = 12A | | 15 | 21 | nC |
| $Q_g$ | Total Gate Charge | $V_{GS}$ = 0V to 5V; $V_{DD}$ = 15V, $I_D$ = 12A | | 8 | 11 | nC |
| $Q_{gs}$ | Gate to Source Charge | $V_{DD}$ = 15V, $I_D$ = 12A | | 2.7 | | nC |
| $Q_{gd}$ | Gate to Drain “Miller” Charge | $V_{DD}$ = 15V, $I_D$ = 12A | | 2.1 | | nC |
| **Drain-Source Diode Characteristics** | | | | | | |
| $V_{SD}$ | Source to Drain Diode Forward Voltage | $V_{GS}$ = 0V, $I_S$ = 2.1A (Note 2) | | 0.7 | 1.2 | V |
| | | $V_{GS}$ = 0V, $I_S$ = 12A | | 0.8 | 1.2 | V |
| $t_{rr}$ | Reverse Recovery Time | $I_F$ = 12A, di/dt = 100A/μs | | 29 | 47 | ns |
| $Q_{rr}$ | Reverse Recovery Charge | | | 14 | 25 | nC |

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1in$^2$ pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 50°C/W when mounted on a 1in$^2$ pad of 2 oz copper.

b. 125°C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300μs, Duty cycle < 2.0%.
3. Starting $T_J$ = 25°C, L = 0.3mH, $I_{AS}$ = 22A, $V_{DD}$ = 30V, $V_{GS}$ = 10V.

## Typical Characteristics $T_J$ = 25°C unless otherwise noted

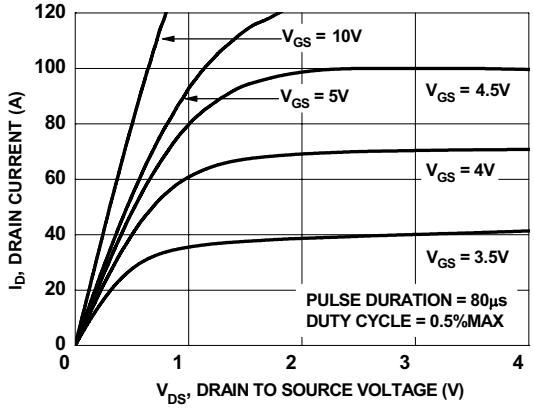



**Figure 1. On-Region Characteristics**

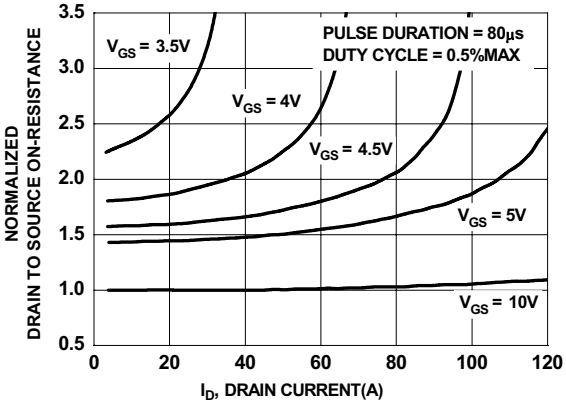



**Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage**

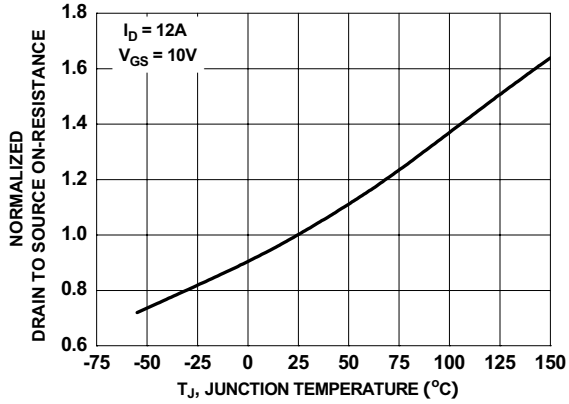



**Figure 3. Normalized On-Resistance vs Junction Temperature**

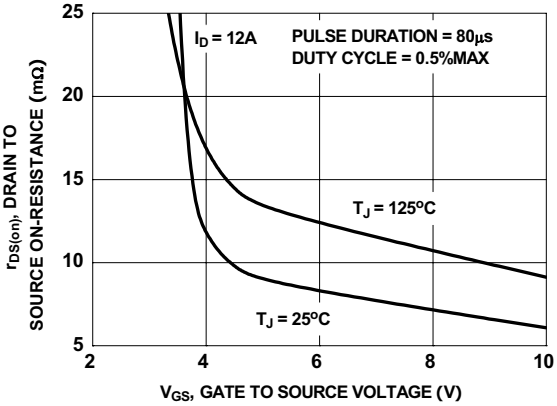



**Figure 4. On-Resistance vs Gate to Source Voltage**

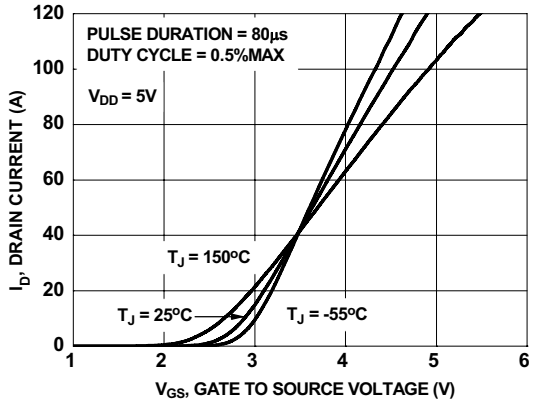



**Figure 5. Transfer Characteristics**

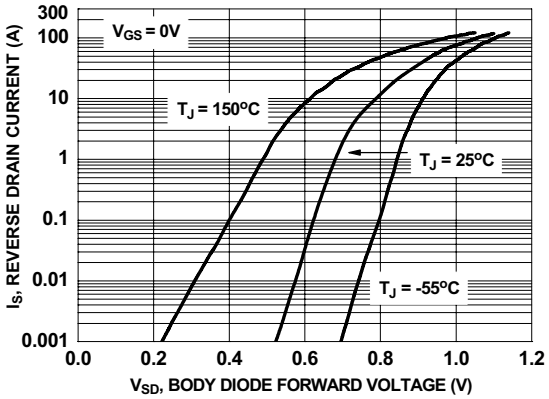



**Figure 6. Source to Drain Diode Forward Voltage vs Source Current**

## Typical Characteristics $T_J$ = 25°C unless otherwise noted

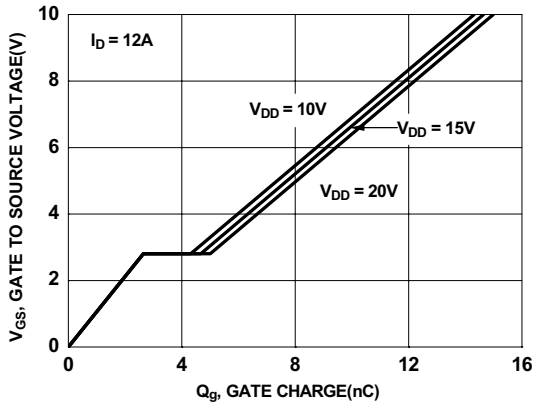



**Figure 7. Gate Charge Characteristics**

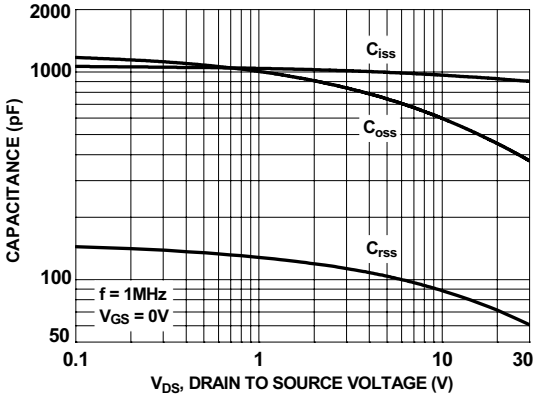



**Figure 8. Capacitance vs Drain to Source Voltage**

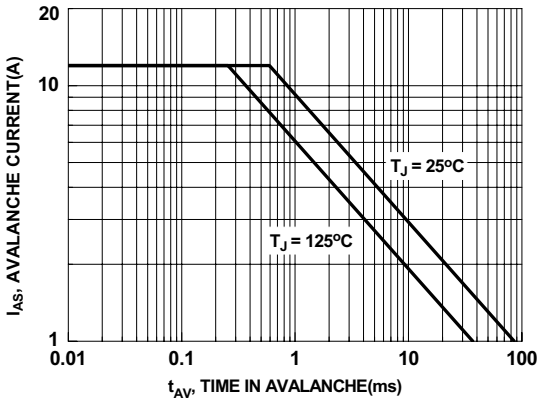



**Figure 9. Unclamped Inductive Switching Capability**

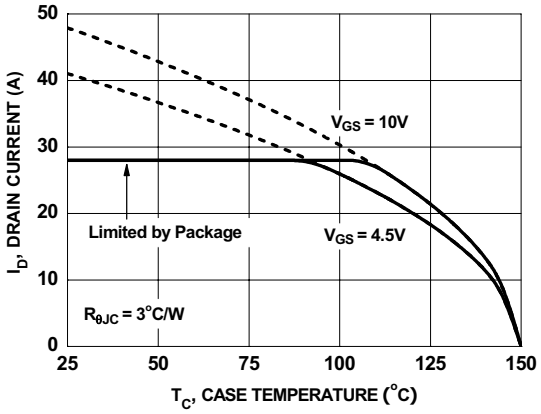



**Figure 10. Maximum Continuous Drain Current vs Case Temperature**

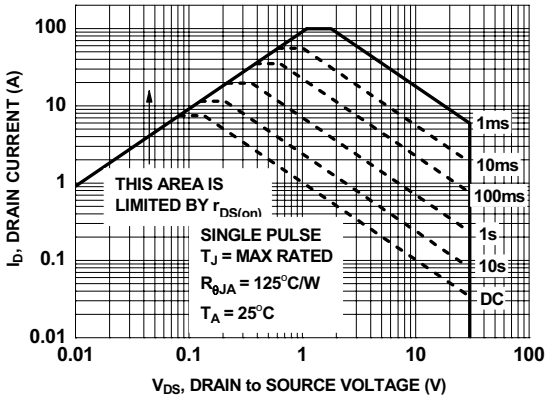



**Figure 11. Forward Bias Safe Operating Area**

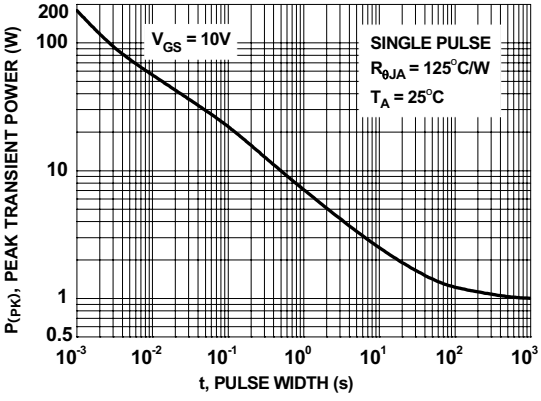



**Figure 12. Single Pulse Maximum Power Dissipation**

## Typical Characteristics $T_J$ = 25°C unless otherwise noted

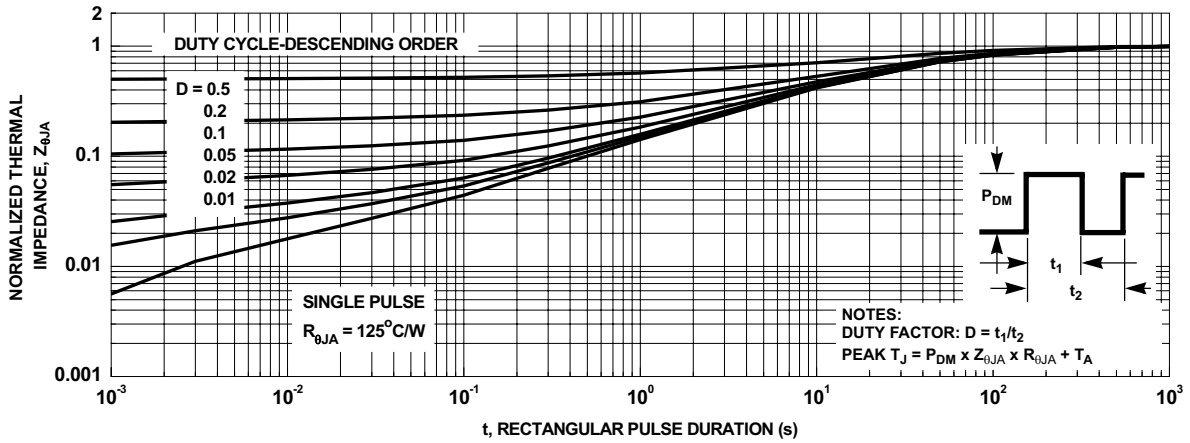
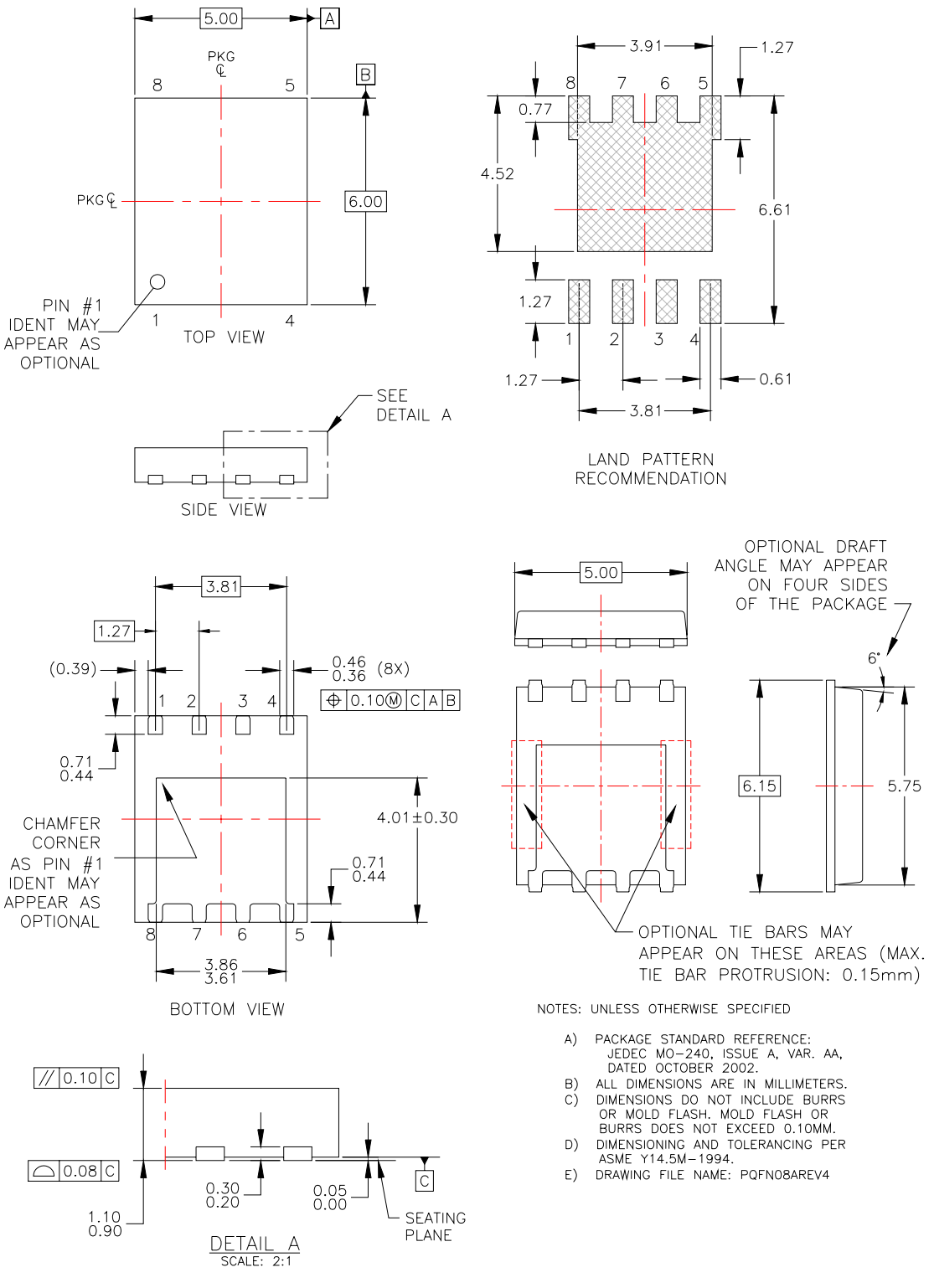



**Figure 13. Transient Thermal Response Curve**

## Dimensional Outline and Pad Layout




NOTES: UNLESS OTHERWISE SPECIFIED

A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. AA, DATED OCTOBER 2002.
B) ALL DIMENSIONS ARE IN MILLIMETERS.
C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
E) DRAWING FILE NAME: PQFN08AREV4

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